

**Search Notes**

Application/Control No.

10/784,047

Examiner

Dang T. Nguyen

Applicant(s)/Patent under  
Reexamination

MUKKER ET AL.

Art Unit

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	191	9/9/2005	DN
365	185.05	9/9/2005	DN
365	63	9/9/2005	DN
365	51	9/9/2005	DN
365	225.7	9/9/2005	DN
365	163	9/9/2005	DN
365	185.18	9/9/2005	DN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
365	191	9/9/2005	DN
365	185.05	9/9/2005	DN
365	63	9/9/2005	DN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB). See search printout.	9/9/2005	DN
Consulted with Primary Phung Anh	9/9/2005	DN
Interference search printout	9/9/2005	DN
365/191 (Text search only, see search history printout)	9/9/2005	DN